## M64894FP/GP

## Serial Input PLL Frequency Synthesizer for TV/VCR

## Description

The M64894 is a semiconductor integrated circuit consisting of PLL frequency synthesizer for TV/VCR using I ${ }^{2}$ C BUS control. It contains the prescaler with operating up to 1.3 GHz .4 band drivers and tuning amplifier for direct tuning. Built-in 4 band drivers.

## Features

- 4 integrated PNP band drivers $\left(\mathrm{I}_{\mathrm{O}}=40 \mathrm{~mA}\right.$, Vsat $=0.2 \mathrm{~V}$ Typ@ $\mathrm{V}_{\mathrm{CC} 1}$ to 13.2 V$)$
- Built-in high-withstanding voltage tuning Amplifier
- Low power dissipation $\left(\mathrm{I}_{\mathrm{CC}}=20 \mathrm{~mA}, \mathrm{~V}_{\mathrm{CC}}=5 \mathrm{~V}\right)$
- Built-in prescaler with input amplifier (Fmax $=1.3 \mathrm{GHz}$ )
- $\mathrm{I}^{2} \mathrm{C}$ bus control (Read and write mode)
- X'tal 4 MHz is used to realize 3 type of tuning steps (Division ratio $1 / 512,1 / 640,1 / 1024$ )
- Built-in 5-level A/D converter
- Programmable chip address
- 16-pin small SOP/SSOP package


## Function

- 2-modulus prescaler ( $1 / 32$ and $1 / 33$ )
- Built-in 4 MHz crystal oscillator and reference divider
- Programmable divider (10-bit M counter, 5-bit S counter)
- Tri-state phase comparator
- Lock detector
- Band switch driver
- Op.Amp for direct tuning
- $\mathrm{I}^{2} \mathrm{C}$ bus receiver
- 5-level A/D converter


## Application

TV, VCR tuners

## Recommended Operating Condition

- Supply voltage range
$-\mathrm{V}_{\mathrm{CC} 1}=4.5$ to 5.5 V
$-\mathrm{V}_{\mathrm{CC} 2}=\mathrm{V}_{\mathrm{CC} 1}$ to 13.2 V
$-\mathrm{V}_{\mathrm{CC} 3}=28$ to 35 V
- Rated supply voltage
$-\mathrm{V}_{\mathrm{CC} 1}=5 \mathrm{~V}$
$-\mathrm{V}_{\mathrm{CC} 2}=12 \mathrm{~V}$
$-\mathrm{V}_{\mathrm{CC} 3}=33 \mathrm{~V}$


## Block Diagram



## Pin Arrangement


(Top view)
Outline: PRSP0016DA-A (16P2S-A) [FP] PRSP0016JA-A (16P2Z-A) [GP]

## Pin Description

| Pin No. | Symbol | Pin name | Function |
| :---: | :---: | :---: | :---: |
| 1 | fin | Prescaler input | Input for the VCO frequency. |
| 2 | GND | GND | Ground to 0 V . |
| 3 | $\mathrm{V}_{\mathrm{CC} 1}$ | Power supply voltage 1 | Power supply voltage terminal. $5.0 \mathrm{~V} \pm 0.5 \mathrm{~V}$ |
| 4 | $\mathrm{V}_{\mathrm{CC} 2}$ | Power supply voltage 2 | Power supply for band switching, $\mathrm{V}_{\mathrm{CC} 1}$ to 13.2 V |
| $\begin{aligned} & 5 \\ & 6 \\ & 7 \\ & 8 \end{aligned}$ | $\begin{aligned} & \text { BS4 } \\ & \text { BS3 } \\ & \text { BS2 } \\ & \text { BS1 } \end{aligned}$ | Band switching outputs | PNP open collector method is used. <br> When the band switching data is " H ", the output is ON . <br> When it is " $L$ ", the output is OFF. |
| 9 | Vin | Filter input (Charge pump output) | This is the output terminal for the LPF input and charge pump output. When the phase of the programmable divider output (f $1 / \mathrm{N}$ ) is ahead compared to the reference frequency ( $\mathrm{f}_{\text {REF }}$ ), the "source" current state becomes active. <br> If it is behind, the "sink" current becomes active. <br> If the phases are the same, the high impedance state becomes active. |
| 10 | Vtu | Tuning output | This supplies the tuning voltage. |
| 11 | VCC3 | Power supply voltage 3 | Power supply voltage for tuning voltage 28 to 35 V |
| 12 | ADC/ftest | AD converter input/ Test port | A/D conversion of the input voltage. <br> In control byte data input, the programmable freq. Divider output and reference freq. output is selected by the test mode. |
| 13 | SCL | Clock input | Data is read into the shift register when the clock signal falls. |
| 14 | SDA | Data input | Input for band SW and programmable freq. divider set up. In lead mode, it outputs lock detector output and power down flag and a state of 5 level A/D converter. |
| 15 | ADS | Address switching input | Chip address sets it up with the input condition of terminal. |
| 16 | Xin | This is connected to the crystal oscillator | 4.0 MHz crystal oscillator is connected. |

## Absolute Maximum Ratings

$\left(\mathrm{Ta}=-20^{\circ} \mathrm{C}\right.$ to $+75^{\circ} \mathrm{C}$, unless otherwise noted)

| Item | Symbol | Ratings | Unit | Condition |
| :--- | :--- | :---: | :---: | :--- |
| Supply voltage 1 | $\mathrm{V}_{\mathrm{CC} 1}$ | 6.0 | V | Pin3 |
| Supply voltage 2 | $\mathrm{V}_{\mathrm{CC} 2}$ | 14.4 | V | Pin4 |
| Supply voltage 3 | $\mathrm{V}_{\mathrm{CC} 3}$ | 36.0 | V | Pin11 |
| Input voltage | $\mathrm{V}_{\mathrm{I}}$ | 6.0 | V | Not to exceed $\mathrm{V}_{\mathrm{CC} 1}$ |
| Output voltage | $\mathrm{V}_{\mathrm{O}}$ | 6.0 | V | $\mathrm{f}_{\mathrm{REF}}$ output |
| Voltage applied when the band <br> output is OFF | $\mathrm{V}_{\mathrm{BSOFF}}$ | 14.4 | V |  |
| Band output current | $\mathrm{I}_{\mathrm{BSON}}$ | 50.0 | mA | Per 1 band output circuit |
| ON the time when the band output <br> is ON | $\mathrm{t}_{\mathrm{BSON}}$ | 10 | s | 50 mA per 1 band output <br> circuit <br> $3 c i r c u i t ~ a r e ~ p n ~ a t ~ s a m e ~ t i m e ~$ |
| Power dissipation |  | Pd | mbO | $\mathrm{Ta}=+75^{\circ} \mathrm{C}$ |
| Operating temperature | Topr | -20 to +75 | ${ }^{\circ} \mathrm{C}$ |  |
| Storage temperature | Tstg | -40 to +125 | ${ }^{\circ} \mathrm{C}$ |  |

## Recommended Operation Conditions

$\left(\mathrm{Ta}=-20^{\circ} \mathrm{C}\right.$ to $+75^{\circ} \mathrm{C}$, unless otherwise noted $)$

| Item | Symbol | Ratings | Unit |  |
| :--- | :--- | :---: | :---: | :--- |
| Supply voltage 1 | $\mathrm{V}_{\mathrm{CC} 1}$ | 4.5 to 5.5 | V | Pin3 |
| Supply voltage 2 | $\mathrm{V}_{\mathrm{CC} 2}$ | $\mathrm{~V}_{\mathrm{CC} 1}$ to 13.2 | V | Pin4 |
| Supply voltage 3 | $\mathrm{V}_{\mathrm{CC} 3}$ | 28 to 35 | V | Pin11 |
| Operating frequency (1) | fopr1 | 4.0 | MHz | Crystal oscillation circuit |
| Operating frequency (2) | fopr2 | 80 to 1,300 | MHz |  |
| Band output current 5 to 8 | $\mathrm{I}_{\mathrm{BDL}}$ | 0 to 40 | mA | Normally 1 circuit is on. 2 circuits on at the <br> same time are max. It is prohibited to have 3 <br> or more circuits turned on at the same time. |

## Electrical Characteristics

| Item |  | Symbol | Test Pin | Limits |  |  | Unit | Test Conditions |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min. |  | Typ. | Max. |  |  |
| Input pin | "H" input voltage |  | $\mathrm{V}_{\mathrm{IH}}$ | $\begin{aligned} & 13 \text { to } \\ & 14 \end{aligned}$ | 3.0 | - | $\begin{gathered} \hline \mathrm{V}_{\mathrm{CC} 1}+ \\ 0.3 \end{gathered}$ | V |  |
|  | "L" input voltage | VIL | $\begin{aligned} & 13 \text { to } \\ & 14 \end{aligned}$ | - | - | 1.5 | V |  |
|  | "H" input current | $\mathrm{I}_{\mathrm{H}}$ | $\begin{aligned} & 13 \text { to } \\ & 14 \end{aligned}$ | - | - | 10 | $\mu \mathrm{A}$ | $\mathrm{V}_{\mathrm{CC} 1}=5.5 \mathrm{~V}, \mathrm{Vi}=4.0 \mathrm{~V}$ |
|  | "L" input current | IIL | 13, 14 | - | -4/-14 | -10/30 | $\mu \mathrm{A}$ | $\mathrm{V}_{\mathrm{CC} 1}=5.5 \mathrm{~V}, \mathrm{Vi}=0.4 \mathrm{~V}$ |
| SDA output | "H" output voltage | VoL | 14 | - | - | 0.4 | $\mu \mathrm{A}$ | $\mathrm{V}_{\mathrm{CC} 1}=5.5 \mathrm{~V}, \mathrm{l}_{\mathrm{o}}=3 \mathrm{~mA}$ |
|  | "L" output voltage | $\mathrm{V}_{\text {LO }}$ | 14 | - | - | 10 | $\mu \mathrm{A}$ | $\mathrm{V}_{\mathrm{CC} 1}=5.5 \mathrm{~V}, \mathrm{~V}_{\mathrm{O}}=5.5 \mathrm{~V}$ |
| Band SW | Output voltage | $\mathrm{V}_{\text {BS }}$ | 5 to 8 | 11.6 | 11.8 | - | V | $\mathrm{V}_{\mathrm{CC} 2}=12 \mathrm{~V}, \mathrm{I}_{0}=-40 \mathrm{~mA}$ |
|  | Leak current | loLk1 | 5 to 8 | - | - | -10 | $\mu \mathrm{A}$ | $\mathrm{V}_{\mathrm{CC} 2}=12 \mathrm{~V}$ band SW is OFF |
| Tuning output | Output voltage "H" | $\mathrm{V}_{\text {TOH }}$ | 10 | 32.5 | - | - | V | $\mathrm{V}_{\mathrm{CC} 3}=33 \mathrm{~V}$ |
|  | Output voltage "L" | $\mathrm{V}_{\text {TOL }}$ | 10 | - | 0.2 | 0.4 | V | $V_{C C 3}=33 \mathrm{~V}$ |
| Charge pump | "H" output current | IOH | 9 | - | 270 | 370 | $\mu \mathrm{A}$ | $\mathrm{V}_{\mathrm{CC} 1}=5.0 \mathrm{~V}, \mathrm{~V}_{\mathrm{O}}=2.5 \mathrm{~V}$ |
|  | "L" output current | l L | 9 | - | 70 | 110 | $\mu \mathrm{A}$ | $\mathrm{V}_{\mathrm{CC} 1}=5.0 \mathrm{~V}, \mathrm{~V}_{\mathrm{O}}=2.5 \mathrm{~V}$ |
|  | Leak current | $I_{\text {CPLK }}$ | 9 | - | - | 50 | nA | $\mathrm{V}_{\mathrm{CC} 1}=5.5 \mathrm{~V}, \mathrm{~V}_{\mathrm{O}}=2.5 \mathrm{~V}$ |
| Supply current 1 |  | $\mathrm{I}_{\mathrm{CC} 1}$ | 3 | - | 20 | 30 | mA | $\mathrm{V}_{\mathrm{CC} 1}=5.5 \mathrm{~V}$ |
| Supply current 2 | 4 circuits: OFF | $\mathrm{I}_{\text {CC2A }}$ | 4 | - | - | 0.3 | mA | $\mathrm{V}_{\mathrm{CC2}}=12 \mathrm{~V}$ |
|  | 1circuits: ON, Output: OPEN | $\mathrm{I}_{\text {CC2B }}$ | 4 | - | 6.0 | 8.0 | mA | $\mathrm{V}_{\mathrm{CC} 2}=12 \mathrm{~V}$ |
|  | Output current 40 mA | $\mathrm{I}_{\mathrm{CC2C}}$ | 4 | - | 46.0 | 48.0 | mA | $\mathrm{V}_{\mathrm{CC} 2}=12 \mathrm{~V} \mathrm{I}_{\mathrm{O}}=-40 \mathrm{~mA}$ |
| Supply current 3 |  | $\mathrm{I}_{\text {CC3 }}$ | 11 | - | 3.0 | 4.0 | mA | $\mathrm{V}_{\mathrm{CC} 3}=12 \mathrm{~V}$ Output ON |

Note: Typical values are measured at $\mathrm{V}_{\mathrm{CC} 1}=5.0 \mathrm{~V}, \mathrm{~V}_{\mathrm{CC} 2}=12 \mathrm{~V}, \mathrm{~V}_{\mathrm{CC} 3}=33 \mathrm{~V}, \mathrm{Ta}=+25^{\circ} \mathrm{C}$.

## Switching Characteristics

$\left(\mathrm{Ta}=-20^{\circ} \mathrm{C}\right.$ to $+75^{\circ} \mathrm{C}, \mathrm{V}_{\mathrm{CC} 1}=5.0 \mathrm{~V}, \mathrm{~V}_{\mathrm{CC} 2}=12 \mathrm{~V}, \mathrm{~V}_{\mathrm{CC} 3}=33 \mathrm{~V}$, unless otherwise noted $)$

| Item | Symbol | Test Pin | Limits |  |  | Unit | Test Conditions |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | Min. | Typ. | Max. |  |  |  |
| Prescaler operating frequency | fopr | 1 | 80 | - | 1300 | MHz | $\begin{aligned} & \hline \mathrm{V}_{\mathrm{CC} 1}=4.5 \text { to } 5.5 \mathrm{~V} \\ & \mathrm{Vin}=\text { Vinmin to Vinmax } \end{aligned}$ |  |
| Operating input voltage | Vin | 1 | -24 | - | 4 | dBm | $\begin{aligned} & \mathrm{V}_{\mathrm{CC} 1}=4.5 \text { to } \\ & 5.5 \mathrm{~V} \end{aligned}$ | 80 to 100 MHz |
|  |  |  | -27 | - | 4 |  |  | 100 to 200 MHz |
|  |  |  | -30 | - | 4 |  |  | 200 to 800 MHz |
|  |  |  | -27 | - | 4 |  |  | 800 to 1000 MHz |
|  |  |  | -18 | - | 4 |  |  | 1000 to 1300 MHz |
| Clock pulse frequency | tscL | 13 | 0 | - | 100 | kHz | $\mathrm{V}_{\mathrm{CC} 1}=4.5$ to 5.5 V |  |
| Bus free time | $\mathrm{t}_{\text {BuF }}$ | 14 | 4.7 | - | - | $\mu \mathrm{S}$ | $\mathrm{V}_{\mathrm{CC} 1}=4.5$ to 5.5 V |  |
| Data hold time | thdsta | 13 | 4 | - | - | $\mu \mathrm{S}$ | $\mathrm{V}_{\text {CC } 1}=4.5$ to 5.5 V |  |
| SCL low hold time | tow | 13 | 4.7 | - | - | $\mu \mathrm{s}$ | $\mathrm{V}_{\mathrm{CC} 1}=4.5$ to 5.5 V |  |
| SCL high hold time | thigh | 13 | 4 | - | - | $\mu \mathrm{s}$ | $\mathrm{V}_{\mathrm{CC} 1}=4.5$ to 5.5 V |  |
| Set up time | tsusta | 13, 14 | 4.7 | - | - | $\mu \mathrm{s}$ | $\mathrm{V}_{\mathrm{CC} 1}=4.5$ to 5.5 V |  |
| Data hold time | thdiat | 13, 14 | 0 | - | - | S | $\mathrm{V}_{\mathrm{CC} 1}=4.5$ to 5.5 V |  |
| Data set up time | $\mathrm{t}_{\text {SUDAT }}$ | 13, 14 | 250 | - | - | ns | $\mathrm{V}_{\mathrm{CC} 1}=4.5$ to 5.5 V |  |
| Rise time | $\mathrm{t}_{\mathrm{r}}$ | 13, 14 | - | - | 1000 | ns | $\mathrm{V}_{\mathrm{CC} 1}=4.5$ to 5.5 V |  |
| Fall time | $\mathrm{t}_{\mathrm{f}}$ | 13, 14 | - | - | 300 | ns | $\mathrm{V}_{\mathrm{CC} 1}=4.5$ to 5.5 V |  |
| Set up time | tsusto | 13, 14 | 4 | - | - | $\mu \mathrm{s}$ | $\mathrm{V}_{\mathrm{CC} 1}=4.5$ to 5.5 V |  |

## Method of Setting Data

The input information to consist of 2 or data of 4 bytes to lead to chip address is received in $\mathrm{I}^{2} \mathrm{C}$ bus receiver. It shows a definition of bus protocol admitted in the following.

| 1_STA | CA | CB | BB | STO |  |  |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- |
| 2_STA | CA | D1 | D2 | STO |  |  |
| 3_STA | CA | CB | BB | D1 | D2 | STO |
| 4_STA | CA | D1 | D2 | CB | BB | STO |
| STA : Start condition |  |  |  |  |  |  |
| STO : Stop condition |  |  |  |  |  |  |
| CA : Chip address |  |  |  |  |  |  |
| CB : Control data byte |  |  |  |  |  |  |
| BB : Band SW data byte |  |  |  |  |  |  |
| D1 : Divider data byte |  |  |  |  |  |  |
| D2 : Divider data byte |  |  |  |  |  |  |

The information of 5 bytes necessary for circuit operation is chip address and control data, band SW data of 2 bytes and divider byte of 2 bytes. After the chip address input, 2 or data of 4 bytes are received.

Function bit is contained the first and the third data byte to distinguish between divider data and control data, band data, and " 0 " goes ahead of divider data, and " 1 " goes ahead of control data, band SW data.


Write Mode Format

| Byte | MSB |  |  |  |  |  |  |  | LSB |
| :--- | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Address byte | 1 | 1 | 0 | 0 | 0 | MA1 | MA0 | 0 | A |
| Divider byte 1 | 0 | N14 | N13 | N12 | N11 | N10 | N9 | N8 | A |
| Divider byte 2 | N7 | N6 | N5 | N4 | N3 | N2 | N1 | N0 | A |
| Control byte1 | 1 | CP | T2 | T1 | T0 | RSa | RSb | OS | A |
| Band SW byte | X | X | X | X | BS4 | BS3 | BS2 | BS1 | A |

Read Mode Format

| Byte | MSB |  |  |  |  |  |  |  | LSB |
| :--- | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Address byte | 1 | 1 | 0 | 0 | 0 | MA1 | MA0 | 1 | A |
| Status byte 1 | POR | FL | X | X | X | A 2 | A 1 | A 0 | A |

## Data Cording Example

## Write Mode Format Example

| Byte | MSB |  |  |  |  |  |  |  | LSB | Condition in Data Setting |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Address Byte | 1 | 1 | 0 | 0 | 0 | 1 | 1 | 0 | 1 | ADS input $\mathrm{V}_{\mathrm{CC} 1}$ |
| Divider byte 1 | 0 | 1 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | Dividing ratio $\mathrm{N}=16544$ |
| Divider byte 2 | 1 | 0 | 1 | 0 | 0 | 0 | 0 | 0 | 1 |  |
| Control byte 1 | 1 | 1 | 0 | 0 | 0 | 0 | 1 | 0 | 1 | C.P.current 270 A fref division ratio 1/1024 |
| Band SW byte | 0 | 0 | 0 | 0 | 1 | 0 | 0 | 0 | 1 | BS4 output ON |

Note: $\mathrm{f}_{\mathrm{vco}}=\mathrm{N} 8 \mathrm{f}_{\text {REF }}=165448(4 \mathrm{MHz} / 1024)=517 \mathrm{MHz}$

Read Mode Format Example

| Byte | MSB |  |  |  |  |  |  |  | LSB | Condition in Data Setting |
| :--- | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Address byte | 1 | 1 | 0 | 0 | 0 | 1 | 1 | 1 | 1 |  |
| Status byte 1 input | 1 | 1 | 1 | 1 | 1 | 1 | 1 | 1 | 1 |  |
| Status byte 1 output | 0 | 1 | 1 | 1 | 1 | 0 | 1 | 1 | 1 | FL "1" output at locked ADC <br> input at open |

## Test Mode Data Set Up Method

## Test Mode Bit Set Up

X
: Random, 0 or 1. normal "0"
MA1, MA0 : Programmable address bit

| Address Input Voltage | MA1 | MA0 |
| :--- | :---: | :---: |
| 0 to $0.1 \pm \mathrm{V}_{\mathrm{CC} 1}$ | 0 | 0 |
| Always valid | 0 | 1 |
| $0.4 \pm \mathrm{V}_{\mathrm{CC} 1}$ to $0.6^{*} \mathrm{~V}_{\mathrm{CC} 1}$ | 1 | 0 |
| $0.9 \pm \mathrm{V}_{\mathrm{CC} 1}$ to $\mathrm{V}_{\mathrm{CC} 1}$ | 1 | 1 |

Note: N14 to N0: How to set dividing ratio of the programmable the divider
Dividing ratio $\mathrm{N}=\mathrm{N} 14\left(2^{14}=16384\right)++\mathrm{N} 0\left(2^{0}=1\right)$
Therefore, the range of division $N$ is 1,024 to 32,768

Example) $\mathrm{f}_{\mathrm{VCO}}=\mathrm{f}_{\text {REF }} \bullet 8 \bullet \mathrm{~N}$

$$
\begin{aligned}
& =3.90625 \cdot 8 \cdot \mathrm{~N} \\
& =31.25 \cdot \mathrm{~N}(\mathrm{kHz})
\end{aligned}
$$

## CP: Setting Up The Charge Pump Current of The Phase Comparator

| CP | Charge pump current | Mode |
| :---: | :---: | :---: |
| 0 | $70 \mu \mathrm{~A}$ | Test |
| 1 | $270 \mu \mathrm{~A}$ | Normal |

T2, T1, T0: Setting Up for The Test Mode

| T2 | T1 | T0 | Charge Pump | Pin 12 Condition | Mode |
| :---: | :---: | :---: | :--- | :--- | :--- |
| 0 | 0 | $X$ | Normal operation | ADC input | Normal operation |
| 0 | 1 | $X$ | High impedance | ADC input | Test mode |
| 1 | 1 | 0 | Sink | ADC input | Test mode |
| 1 | 1 | 1 | Source | ADC input | Test mode |
| 1 | 0 | 0 | High impedance | f REF $^{\text {f1/ output }}$ | Test mode |
| 1 | 0 | 1 | High impedance | f1/N output | Test mode |

RSa, RSb: Set Up for The Reference Frequency Division Ratio

| RSa | RSb | Division Ratio |
| :---: | :---: | :---: |
| 1 | 1 | $1 / 512$ |
| 0 | 1 | $1 / 1024$ |
| $X$ | 0 | $1 / 640$ |

## OS: Set Up The Tuning Amplifier

| OS | Tuning Voltage Output | Mode |
| :---: | :---: | :---: |
| 0 | ON | Normal |
| 1 | OFF | Test |

POR : Power on reset flag. " 1 " output at reset
FL : Lock detector flag. " 1 " output at locked, " 0 " output at unlocked

A2, A1, A0: 5 Level A/D Converter Output Data

| ADC Input Voltage | A2 | A1 | A0 |
| :--- | :---: | :---: | :---: |
| $0.6 \pm \mathrm{V}_{\mathrm{CC} 1}$ to $\mathrm{V}_{\mathrm{CC} 1}$ | 1 | 0 | 0 |
| $0.45 \pm \mathrm{V}_{\mathrm{CC} 1}$ to $0.6 \pm \mathrm{V}_{\mathrm{CC} 1}$ | 0 | 1 | 1 |
| $0.3 \pm \mathrm{V}_{\mathrm{CC} 1}$ to $0.45 \pm \mathrm{V}_{\mathrm{CC} 1}$ | 0 | 1 | 0 |
| $0.15 \pm \mathrm{V}_{\mathrm{CC} 1}$ to $0.3 \pm \mathrm{V}_{\mathrm{CC} 1}$ | 0 | 0 | 1 |
| 0 to $0.15 \pm \mathrm{V}_{\mathrm{CC} 1}$ | 0 | 0 | 0 |

Note: The voltage accuracy allowance range: $0.03 \pm \mathrm{V}_{\mathrm{CC} 1}(\mathrm{~V})$

## Power On Reset Operation

(Initial state the power is turned ON )

| BS4 to BS1 | $:$ OFF |
| :--- | :--- |
| Charge pump | $:$ High impedance |
| Tuning amplifier | $:$ OFF |
| Charge pump current | $: 270 \mu \mathrm{~A}$ |
| Frequency division ratio | $: 1 / 1024$ |

## Timing Diagram



## Crystal Oscillator Connection Diagram

| 16 |  |
| :--- | :--- |
| Crystal oscillator characteristics |  |
| In pF | Actual resistance: less than $300 \Omega$ |
| Load capacitance: 20 pF |  |

## Application Example



## Package Dimensions




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